International Rectifier

AUTOMOTIVE MOSFET

IRF2907Z IRF2907ZS IRF2907ZL

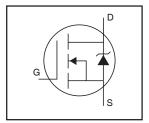
Features

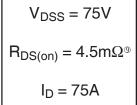
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax

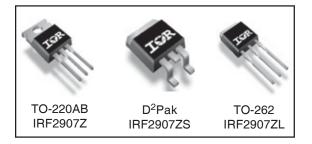
Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.









Absolute Maximum Ratings

Parameter	Max.	Units	
Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	170	Α	
Continuous Drain Current, V _{GS} @ 10V (See Fig. 9)	120	1	
Continuous Drain Current, V _{GS} @ 10V (Package Limited)	75		
Pulsed Drain Current ①	680		
Maximum Power Dissipation	330	W	
Linear Derating Factor	2.2	W/°C	
Gate-to-Source Voltage	± 20	V	
Single Pulse Avalanche Energy (Thermally Limited) ②	300	mJ	
Single Pulse Avalanche Energy Tested Value ⑦	690		
Avalanche Current ①	See Fig.12a,12b,15,16	Α	
Repetitive Avalanche Energy ®		mJ	
Operating Junction and	-55 to + 175	°C	
Storage Temperature Range			
Soldering Temperature, for 10 seconds	300 (1.6mm from case)		
Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)		
	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) Continuous Drain Current, V _{GS} @ 10V (See Fig. 9) Continuous Drain Current, V _{GS} @ 10V (Package Limited) Pulsed Drain Current ① Maximum Power Dissipation Linear Derating Factor Gate-to-Source Voltage Single Pulse Avalanche Energy (Thermally Limited) ② Single Pulse Avalanche Energy Tested Value ② Avalanche Current ① Repetitive Avalanche Energy ⑤ Operating Junction and Storage Temperature Range Soldering Temperature, for 10 seconds	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) Continuous Drain Current, V _{GS} @ 10V (See Fig. 9) Continuous Drain Current, V _{GS} @ 10V (Package Limited) Pulsed Drain Current ① 680 Maximum Power Dissipation Linear Derating Factor 2.2 Gate-to-Source Voltage Single Pulse Avalanche Energy (Thermally Limited) ② Single Pulse Avalanche Energy Tested Value ② Avalanche Current ① See Fig.12a,12b,15,16 Repetitive Avalanche Energy ® Operating Junction and Storage Temperature Range Soldering Temperature, for 10 seconds 120 120 120 120 120 120 120 12	

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		0.45	°C/W
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50		
$R_{\theta JA}$	Junction-to-Ambient ®		62	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount, steady state)®®		40	

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Static @ $T_J = 25$ °C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	75			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.069		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		3.5	4.5	mΩ	V _{GS} = 10V, I _D = 75A ⊕
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Transconductance	180			S	$V_{DS} = 25V, I_{D} = 75A$
I _{DSS}	Drain-to-Source Leakage Current			20	μΑ	$V_{DS} = 75V$, $V_{GS} = 0V$
				250	1	$V_{DS} = 75V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			200	nA	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-200	1	V _{GS} = -20V
Q_g	Total Gate Charge		180	270		I _D = 75A
Q_{gs}	Gate-to-Source Charge		46		nC	$V_{DS} = 60V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		65		1	V _{GS} = 10V ⊕
t _{d(on)}	Turn-On Delay Time		19		ns	$V_{DD} = 38V$
t _r	Rise Time		140		1	$I_D = 75A$
t _{d(off)}	Turn-Off Delay Time		97		1	$R_G = 2.5\Omega$
t _f	Fall Time		100		1	V _{GS} = 10V ⊕
L _D	Internal Drain Inductance		5.0		nΗ	Between lead,
						6mm (0.25in.)
L _S	Internal Source Inductance		13		1	from package
						and center of die contact
C _{iss}	Input Capacitance		7500		pF	$V_{GS} = 0V$
C _{oss}	Output Capacitance		970		İ	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		510		ĺ	f = 1.0MHz, See Fig. 5
C _{oss}	Output Capacitance		3640		ĺ	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
C _{oss}	Output Capacitance		650		ĺ	$V_{GS} = 0V, V_{DS} = 60V, f = 1.0MHz$
C _{oss} eff.	Effective Output Capacitance		1020		1	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 60V$

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			75		MOSFET symbol
	(Body Diode)				Α	showing the
I _{SM}	Pulsed Source Current			680		integral reverse
	(Body Diode) ①					p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25$ °C, $I_S = 75A$, $V_{GS} = 0V$ ④
t _{rr}	Reverse Recovery Time		41	61		$T_J = 25^{\circ}C$, $I_F = 75A$, $V_{DD} = 38V$
Q_{rr}	Reverse Recovery Charge		59	89	nC	di/dt = 100A/μs ④
t _{on}	Forward Turn-On Time	Intrinsi	turn-or	time is	negligib	le (turn-on is dominated by LS+LD)

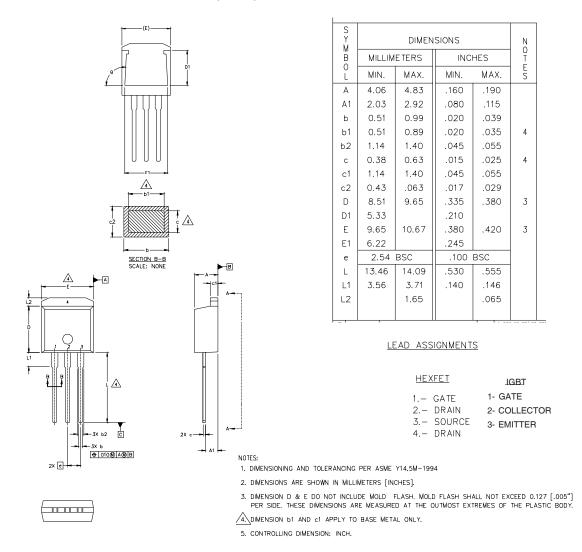
Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Limited by T_{Jmax} , starting $T_J = 25^{\circ}C$, L=0.11mH, $R_G = 25\Omega$, $I_{AS} = 75A$, $V_{GS} = 10V$. Part not recommended for use above this value.
- $\label{eq:loss} \begin{array}{l} \text{ } \exists \ I_{SD} \leq 75A, \ di/dt \leq 340A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \\ T_{J} \leq 175^{\circ}C. \end{array}$
- 4 Pulse width \leq 1.0ms; duty cycle \leq 2%.
- ⑥ Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- This value determined from sample failure population. 100% tested to this value in production.
- ® This is applied to D²Pak, when mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.

IRF2907Z/S/L

TO-262 Package Outline

Dimensions are shown in millimeters (inches)



TO-262 Part Marking Information

EXAMPLE: THIS IS AN IRL3103L LOT CODE 1789 ASSEMBLED ON WW 19, 1997 IN THE ASSEMBLY LINE "C"

